

2-20GHz Broadband MMIC Amplifier

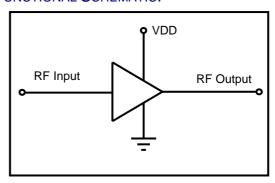
FEATURES:

- Cascode Configuration
- 10dB Gain
- Single Supply
- 23dBm P_{1dB} Output Power at 8.0V
- pHEMT Technology
- Bias Control
- Input Return Loss <-10dB
- Output Return Loss <-10dB

GENERAL DESCRIPTION:

The FMA3009 is a high performance 2-20GHz Gallium Arsenide monolithic travelling wave amplifier. It is suitable for use in broadband communication, instrumentation and electronic warfare applications. The die is fabricated using the Filtronic 0.25µm process. The Circuit is DC blocked at both the RF input and the RF output. Bias control is achieved using a combination of three on chip bias resistors connected to ground, using the bond wires.

FUNCTIONAL SCHEMATIC:



TYPICAL APPLICATIONS:

- Test Instrumentation
- Electronic Warfare
- Broadband Communication Infrastructure

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ELECTRICAL SPECIFICATIONS:

PARAMETER	Conditions	Min	Түр	Max	Units
Small Signal Gain	2-20GHz	9.0	10		dB
Gain Ripple	2-20GHz		±0.7		dB
Input Return Loss	2-20GHz		<-10		dB
Output Return Loss	2-20GHz		<-10		dB
Reverse Isolation	2-20GHz		<-45		dB
Output Power at 1dB compression point	10GHz 20GHz		27 22		dBm
Power Roll-off	2-20GHz		5		dB
Saturated Output Power	10GHz 20GHz		28 24		dBm
Drain Current	8.0V		287		mA

Note: $T_{AMBIENT} = +25$ °C, $Z_0 = 50\Omega$

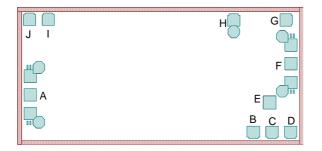


Preliminary Datasheet v2.1

ABSOLUTE MAXIMUM RATINGS:

PARAMETER	SYMBOL	ABSOLUTE MAXIMUM
Max Input Power	Pin	+25dBm
Gate Voltage	VG1	-2V
Drain Voltage	VDD	+10V
Total Power Dissipation	Ptot	tbd
Gain Compression	Comp	tbd
Thermal Resistivity	θЈС	0.66°C/W
Operating Temp	Toper	-40°C to +85°C
Storage Temp	Tstor	-55°C to +150°C

Note: Exceeding any one of these absolute maximum ratings may cause permanent damage to the device.



PAD LAYOUT:

PAD REF	Pad Name	DESCRIPTION	PIN COORDINATES (µm)
Α	IN	RF in	(100,396)
В	R1		(1896,100)
С	R2	Source Resistors	(2046, 100)
D	R3		(2196, 100)
E	Source	Resistor bypass bond pad	(2027, 337)
F	OUT	RF Output	(2200, 650)
G	VDD	Drain Voltage	(2156, 1000)
Н	GND	Ground	(1738, 995)
ı	R5	Cascode Resistor	(245, 1000)
J	R4	Cascode Resistor	(95, 1000)

Note: Co-ordinates are referenced from the bottom left hand corner of the die to the centre of bond pad opening

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DIE SIZE (μm)	DIE THICKNESS (μm)	Min. Bond Pad Pitch (μm)	Min. Bond pad Opening (μm x μm)
2300 x 1100	100	150	100 x 100

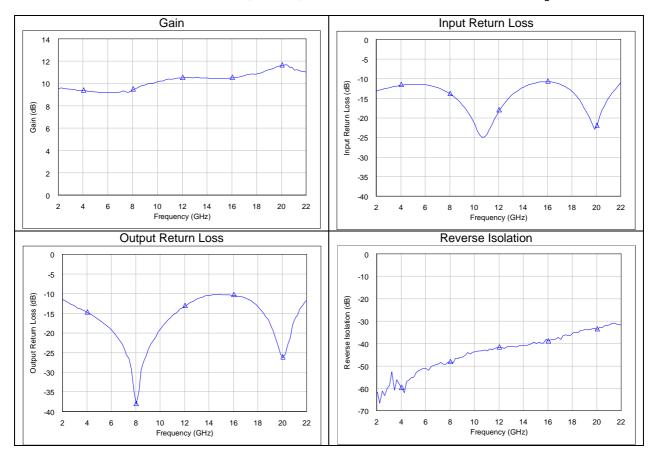
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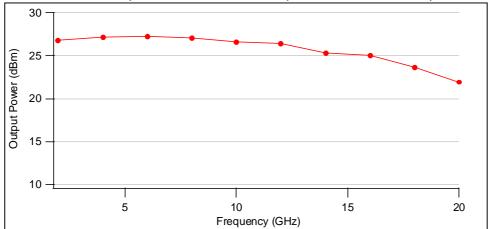


TYPICAL PERFORMANCE FOR ON WAFER MEASUREMENTS:

Note: Measurement Conditions I_D= 240mA, V_{DD}= 8V, T_{AMBIENT} = 25°C. All Bias resistors bonded to ground





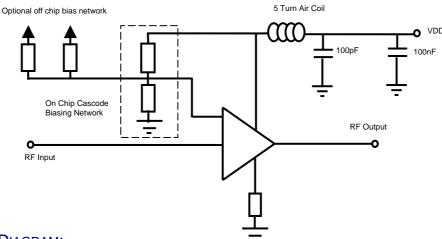




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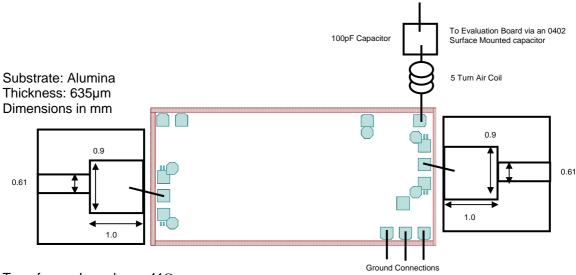


BIASING CIRCUIT SCHEMATIC:



ASSEMBLY DIAGRAM:

It is recommended that the RF connections be made using two bond wires $25\mu m$ in diameter and a maximum length of $300\mu m$. Optimum input and output return loss can be achieved, to compensate for bond wire length, with the addition of a microstrip transformer, shown in the diagram below. Ground connections should be made according to the required bias conditions.



Transformer Impedance 41Ω Electrical Length 32° at 10GHz

BILL OF MATERIALS:

COMPONENT	
All RF tracks should be 50Ω characteristic material	
Capacitor, 100pF, chip capacitor	
Capacitor, 100pF, 0402	
5 Turn Air Coil (Manufacturer: Sycopel)	

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PREFERRED ASSEMBLY INSTRUCTIONS:

GaAs devices are fragile and should be handled with great care. Specially designed collets should be used where possible.

The recommended die attach is gold/tin eutectic solder under a nitrogen atmosphere. Stage temperature should be 280-290°C; maximum time at temperature is one minute. The recommended wire bond method is thermo-compression wedge bonding with 0.7 or 1.0 mil (0.018 or 0.025 mm) gold wire. Stage temperature should be 250-260°C.

Bonds should be made from the die first and then to the mounting substrate or package. The physical length of the bondwires should be minimised especially when making RF or ground connections.

HANDLING PRECAUTIONS:



To avoid damage to the devices care should be exercised during handling. Proper Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing. These devices should be treated as Class 1A (0-500 V) as defined in JEDEC Standard No. 22-A114. Further information on ESD control measures can be found in MIL-STD-1686 and MIL-HDBK-263.

APPLICATION NOTES & DESIGN DATA:

Application Notes and design data including Sparameters, noise data and large-signal models are available on request.

DISCLAIMERS:

This product is not designed for use in any space based or life sustaining/supporting equipment.

ORDERING INFORMATION:

PART NUMBER	DESCRIPTION	
FMA3009	Die in Waffle-pack	
	(Gel-pak available on request)	